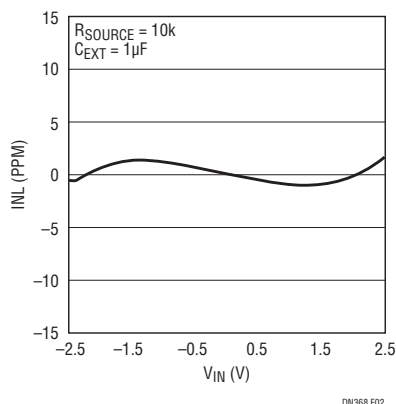




total error introduced by the external RC network is zero if the resistance tied to the plus/minus inputs of the ADC is balanced. Resistances up to 100k, combined with capacitors up to 10 $\mu$ F may be placed in front of the ADC with less than 0.002% full-scale error (20ppm), while conventional  $\Delta\Sigma$  ADCs with the same input network have greater than 10% full-scale errors (100,000ppm). Furthermore, no errors are introduced even if the external resistances are not balanced, as long as the common mode input voltage is equal to the common mode reference voltage. Even if the common mode input voltage does not match the common mode reference voltage, the differential input current remains zero and the common mode input current results in an offset voltage which may be removed through system calibration.

Direct digitization of external sensors with impedances up to 100k $\Omega$  is now possible without the need for external or on-chip amplifiers (see Figure 2). Bridges, RTDs, thermocouples and other sensors may tie directly to the ADC input. The addition of external capacitors reduces the charge kickback spikes seen at the input of the ADC. An external 1 $\mu$ F capacitor reduces a 1V spike to 18 $\mu$ V. This improves the noise performance of systems where the sensor cannot be placed near the ADC input and eases the drive requirements in applications where external amplifiers are used. The addition of a large resistor between the amplifier output and the ADC input isolates the amplifier from the large bypass capacitor, thus improving its stability.



**Figure 2. Easy Drive Technology Directly Digitizes Large External RC Networks Without Degrading Linearity**

### What is Wrong with On-Chip Buffers?

One historical solution to the input current settling problem is to integrate a buffer amplifier on the same

chip as the  $\Delta\Sigma$  ADC. This isolates the ADC input from the switched capacitor array making the ADC input appear high impedance. While this solution looks good on paper, the fact is data converters using on-chip buffers suffer from the limitations of those amplifiers. The common mode input range can no longer swing rail-to-rail. Input signals need to be shifted at least 50mV above ground and a volt or more below  $V_{CC}$ . Amplifier offset errors, offset drift, PSRR, CMRR and noise are combined directly with the input signal and result in reduced converter performance. Additionally, on-chip amplifiers require significant power in order to drive the high speed capacitive sampling network. For these reasons, most manufacturers of  $\Delta\Sigma$  ADCs using this technology offer a mode to shut off and bypass on-chip amplifiers.

Another solution is coarse/fine input sampling. During the first half of the sampling period (coarse), the input voltage is sampled through an on-chip buffer amplifier, thus isolating the ADC input from the charging capacitor. During the second half of the sampling period (fine), the buffer is switched off and the capacitor is tied directly to the input. While this decreases the magnitude of the spikes seen at the input of the ADC, it results in nonlinear settling errors as a function of op amp offset voltage, CMRR, input signal level and external RC time constants. For these reasons, manufacturer's of  $\Delta\Sigma$  ADCs using this technology bypass coarse/fine sampling for input signal levels below 100mV.

### Conclusion

New Easy Drive technology simplifies the drive requirements of  $\Delta\Sigma$  ADCs. The solution lies in a purely passive input current cancellation algorithm that enables rail-to-rail inputs without the added power requirements of on-chip buffer amplifiers and the errors they introduce. Easy Drive technology enables  $\Delta\Sigma$  ADCs to directly interface to high impedance sensors, lowpass filters and input bypass capacitors without degrading the DC performance.

Devices using the Easy Drive technology are currently available in 16- and 24-bit versions with an on-chip temperature sensor, no latency conversions for simple multiplexing, on-chip oscillators with guaranteed line frequency rejection, precise DC specifications and the ease-of-use common to all of Linear's  $\Delta\Sigma$  ADC converters.

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